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## BIR DATA SHEET

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	RUL										
APPLICANTS Kenji Watanabe, Kanagawa, JAPAN; Takeshi Murakami, Tokyo, JAPAN; Masahiro Hatakeyama, Kanagawa, JAPAN; Yoshinao Hirabayashi, Nagano, JAPAN; Yoshinao Hirabayashi, Nagano, JAPAN; Tohru Satake, Kanagawa, JAPAN; Nobuharu Noji, Kanagawa, JAPAN; Yuichiro Yamazaki, Tokyo, JAPAN; Yuichiro Yamazaki, Tokyo, JAPAN; CONTINUING DATA This application is a 371 of PCT/JP04/00711 01/27/2004  *FOREIGN APPLICATIONS JAPAN 2003-016987 01/27/2003											
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WESTERMAN, HATTORI, DANIELS & ADRIAN, LLP 1250 CONNECTICUT AVENUE, NW SUITE 700 WASHINGTON, DC 20036 UNITED STATES											
TITLE											
Mapping-projection-type electron beam apparatus for inspecting sample by using electrons reflected from the sample											
RECEIVED	FEES: Authority has been given in Paper  No to charge/credit DEPOSIT ACCOUNT  No for following:    1.16 Fees (Filing)     1.17 Fees (Processing Ext. of time)     1.18 Fees (Issue)     Other     Credit								ing Ext. of time)		